# **Power MOSFET**

# 60 V, 1.5 m $\Omega$ , 235 A, Single N-Channel

#### **Features**

- Small Footprint (5x6 mm) for Compact Design
- Low R<sub>DS(on)</sub> to Minimize Conduction Losses
- Low Q<sub>G</sub> and Capacitance to Minimize Driver Losses
- NTMFS5C612NLWF Wettable Flank Option for Enhanced Optical Inspection
- These Devices are Pb-Free and are RoHS Compliant

#### **MAXIMUM RATINGS** (T<sub>J</sub> = 25°C unless otherwise noted)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			V <sub>DSS</sub>	60	V
Gate-to-Source Voltage	Gate-to-Source Voltage			±20	V
Continuous Drain	Steady	T <sub>C</sub> = 25°C	I <sub>D</sub>	235	Α
Current R <sub>θJC</sub> (Notes 1, 3)		T <sub>C</sub> = 100°C		166	
Power Dissipation	State	T <sub>C</sub> = 25°C	$P_{D}$	167	W
R <sub>θJC</sub> (Note 1)		T <sub>C</sub> = 100°C		83	
Continuous Drain Current R <sub>0.IA</sub>		T <sub>A</sub> = 25°C	I <sub>D</sub>	36	Α
(Notes 1, 2, 3)	Steady	T <sub>A</sub> = 100°C		25	
Power Dissipation	State $T_A = 25^{\circ}C$		P <sub>D</sub>	3.8	W
R <sub>θJA</sub> (Notes 1 & 2)		T <sub>A</sub> = 100°C		1.9	
Pulsed Drain Current	$T_A = 25^{\circ}C$ , $t_p = 10 \mu s$		I <sub>DM</sub>	900	Α
Operating Junction and Storage Temperature			T <sub>J</sub> , T <sub>stg</sub>	-55 to +175	ç
Source Current (Body Diode)			I <sub>S</sub>	164	Α
Single Pulse Drain-to-Source Avalanche Energy (I <sub>L(pk)</sub> = 17 A)			E <sub>AS</sub>	451	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			TL	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

### THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case - Steady State	$R_{\theta JC}$	0.9	°C/W
Junction-to-Ambient - Steady State (Note 2)	$R_{\theta JA}$	39	

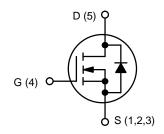
- The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
- 2. Surface-mounted on FR4 board using a 650 mm<sup>2</sup>, 2 oz. Cu pad.
- Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle.



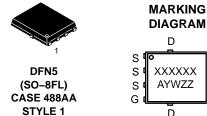
## ON Semiconductor®

#### www.onsemi.com

V <sub>(BR)DSS</sub>	R <sub>DS(ON)</sub> MAX	I <sub>D</sub> MAX	
60 V	1.5 mΩ @ 10 V	005.4	
	2.3 mΩ @ 4.5 V	235 A	



**N-CHANNEL MOSFET** 



XXXXXX = 5C612L

(NTMFS5C612NL) or

D

612LWF

(NTMFS5C612NLWF) = Assembly Location

A = Assembly Locat Y = Year W = Work Week

ZZ = Lot Traceability

#### **ORDERING INFORMATION**

See detailed ordering, marking and shipping information in the package dimensions section on page 5 of this data sheet.

# **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = 25°C unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit	
OFF CHARACTERISTICS	•						•	
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		60			V	
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /				12.7		mV/°C	
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	$V_{GS} = 0 V$	T <sub>J</sub> = 25 °C			1.0		
		V <sub>DS</sub> = 60 V	T <sub>J</sub> = 125°C			250 μΑ		
Gate-to-Source Leakage Current	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS}$	<sub>S</sub> = 20 V			100	nA	
ON CHARACTERISTICS (Note 4)								
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_{D} = 250 \mu A$		1.2		2.0	V	
Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>				-5.76		mV/°C	
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V	I <sub>D</sub> = 50 A		1.2	1.5		
		V <sub>GS</sub> = 4.5 V	I <sub>D</sub> = 50 A		1.65	2.3	mΩ	
Forward Transconductance	9FS	V <sub>DS</sub> = 15 V, I <sub>D</sub>	o = 50 A		151		S	
CHARGES, CAPACITANCES & GATE R	ESISTANCE							
Input Capacitance	C <sub>ISS</sub>				6660			
Output Capacitance	C <sub>OSS</sub>	$V_{GS} = 0 \text{ V, f} = 1 \text{ MHz, } V_{DS} = 25 \text{ V}$			2953		pF	
Reverse Transfer Capacitance	C <sub>RSS</sub>				45			
Total Gate Charge	Q <sub>G(TOT)</sub>	$V_{GS} = 4.5 \text{ V}, V_{DS} = 30 \text{ V}; I_D = 50 \text{ A}$			41			
Total Gate Charge	Q <sub>G(TOT)</sub>	$V_{GS} = 10 \text{ V}, V_{DS} = 30 \text{ V}; I_D = 50 \text{ A}$			91			
Threshold Gate Charge	Q <sub>G(TH)</sub>	$V_{GS} = 4.5 \text{ V}, V_{DS} = 30 \text{ V}; I_D = 50 \text{ A}$			5		nC	
Gate-to-Source Charge	Q <sub>GS</sub>				17.1			
Gate-to-Drain Charge	$Q_{GD}$				10.9			
Plateau Voltage	$V_{GP}$				2.9		V	
SWITCHING CHARACTERISTICS (Note	5)							
Turn-On Delay Time	t <sub>d(ON)</sub>				19			
Rise Time	t <sub>r</sub>	VGS = 4.5 V. VD	s = 30 V.		51		1	
Turn-Off Delay Time	t <sub>d(OFF)</sub>	$V_{GS} = 4.5 \text{ V}, V_{DS} = 30 \text{ V},$ $I_{D} = 50 \text{ A}, R_{G} = 1.0 \Omega$			47		ns -	
Fall Time	t <sub>f</sub>				18			
DRAIN-SOURCE DIODE CHARACTERI	STICS				•			
Forward Diode Voltage	V <sub>SD</sub>	V <sub>GS</sub> = 0 V,	T <sub>J</sub> = 25°C		0.78	1.2	.,	
		$I_S = 50 \text{ A}^{\prime}$	T <sub>J</sub> = 125°C		0.66		V	
Reverse Recovery Time	t <sub>RR</sub>	$V_{GS} = 0 \text{ V, dIS/dt} = 100 \text{ A/}\mu\text{s,}$ $I_{S} = 50 \text{ A}$			78			
Charge Time	ta				36		ns	
Discharge Time	t <sub>b</sub>				42		1	
Reverse Recovery Charge	Q <sub>RR</sub>				105		nC	

- 4. Pulse Test: pulse width  $\leq 300~\mu s$ , duty cycle  $\leq 2\%$ . 5. Switching characteristics are independent of operating junction temperatures.

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

#### **TYPICAL CHARACTERISTICS**

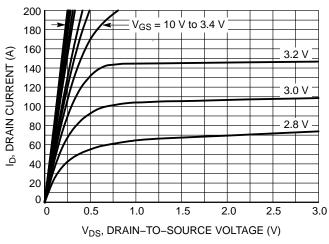


Figure 1. On-Region Characteristics

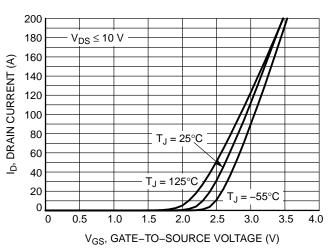


Figure 2. Transfer Characteristics

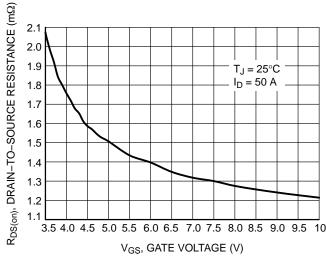


Figure 3. On–Resistance vs. Gate–to–Source Voltage

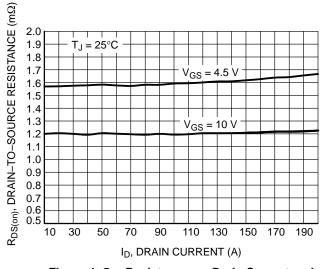


Figure 4. On–Resistance vs. Drain Current and Gate Voltage

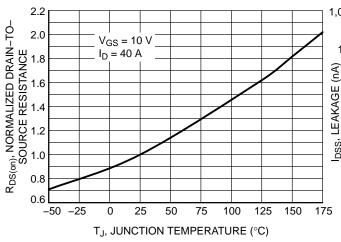


Figure 5. On–Resistance Variation with Temperature

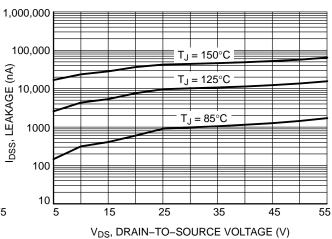


Figure 6. Drain-to-Source Leakage Current vs. Voltage

#### TYPICAL CHARACTERISTICS

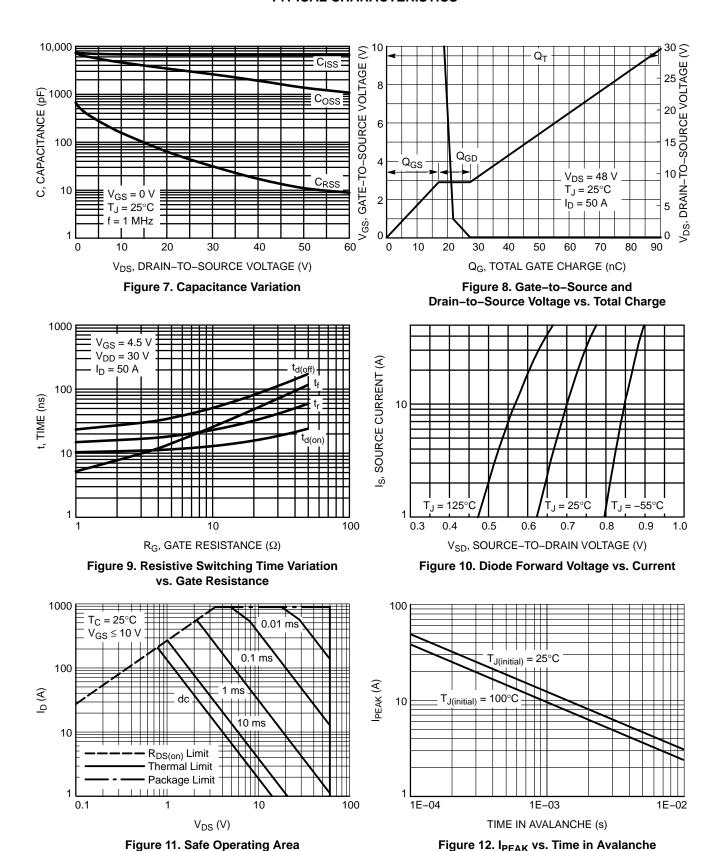


Figure 12.  $I_{\mbox{\scriptsize PEAK}}$  vs. Time in Avalanche

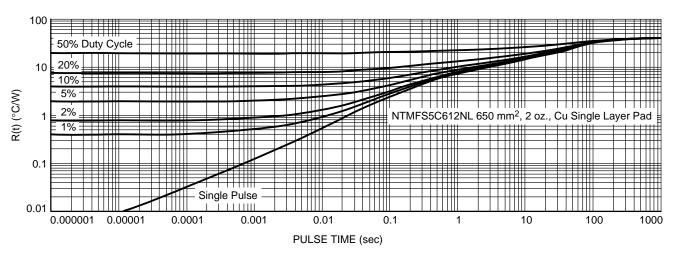


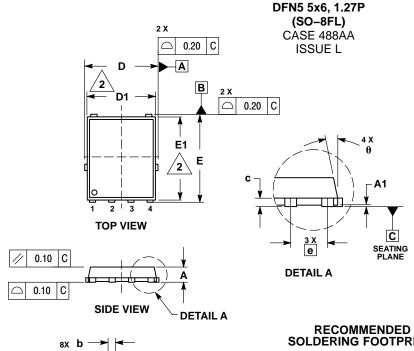
Figure 13. Thermal Characteristics

## **DEVICE ORDERING INFORMATION**

Device	Marking	Package	Shipping <sup>†</sup>
NTMFS5C612NLT1G	5C612L	DFN5 (Pb-Free)	1500 / Tape & Reel
NTMFS5C612NLWFT1G	612LWF	DFN5 (Pb-Free, Wettable Flanks)	1500 / Tape & Reel
NTMFS5C612NLT3G	5C612L	DFN5 (Pb-Free)	5000 / Tape & Reel

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

#### PACKAGE DIMENSIONS



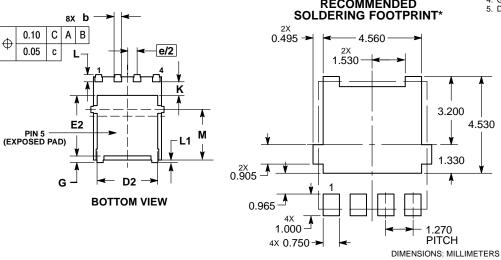
#### NOTES:

- DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
- ASWIE 114.5W, 1894.
  CONTROLLING DIMENSION: MILLIMETER.
  DIMENSION D1 AND E1 DO NOT INCLUDE
  MOLD FLASH PROTRUSIONS OR GATE
  BURRS.

	MILLIMETERS			
DIM	MIN	NOM	MAX	
Α	0.90	1.00	1.10	
A1	0.00		0.05	
b	0.33	0.41	0.51	
С	0.23	0.28	0.33	
D	5.00	5.15	5.30	
D1	4.70	4.90	5.10	
D2	3.80	4.00	4.20	
E	6.00	6.15	6.30	
E1	5.70	5.90	6.10	
E2	3.45	3.65	3.85	
е		1.27 BSC		
G	0.51	0.61	0.71	
K	1.20	1.35	1.50	
L	0.51	0.61	0.71	
L1	0.125 REF			
М	3.00	3.40	3.80	
θ	0 °		12 °	

STYLE 1: PIN 1. SOURCE 2. SOURCE 3. SOURCE

GATE DRAIN



\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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